

**Search Notes**

Application/Control No.

10/766,818

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under  
Reexamination

YOSHIDA, MASAHIITO

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	22,29,33 32,35,36 31	12/23/2005	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR